

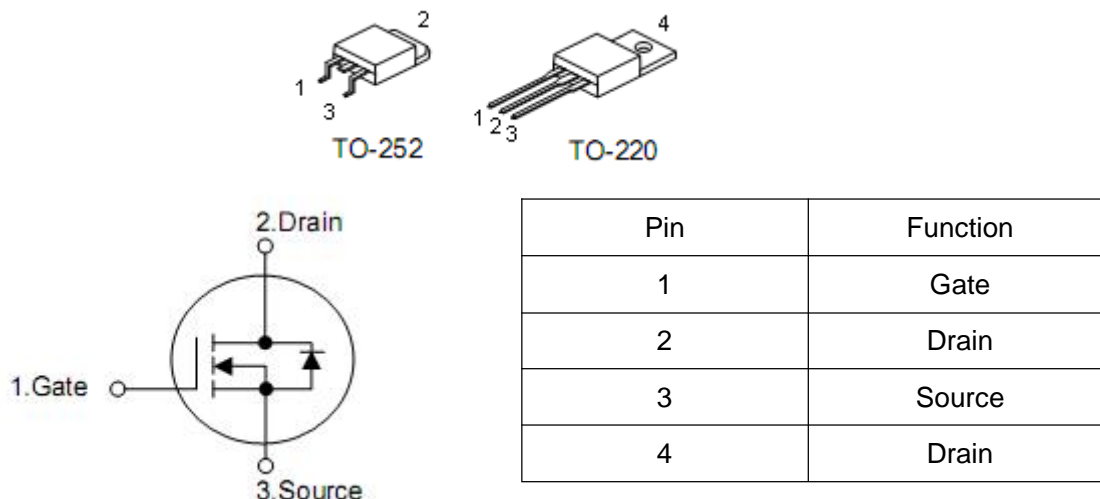
## 1. Features

- n  $R_{DS(ON),typ.}=9m\Omega@V_{GS}=10V$
- n 100% EAS guaranteed
- n Super low gate charge
- n Excellent Cdv/dt effect decline
- n Advanced high cell density trench technology

## 2. Description

The KNX3706A is the high cell density trenched N-ch MOSFET ,which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications. The KNX3706A meet the RoHS and Green product requirement, 100% EAS guaranteed with full function reliability approved.

## 3. Symbol



## 4. Absolute maximum ratings

| Parameter   | Symbol          | Rating            |                | Units     |   |
|---|-----------------|-------------------|----------------|-----------|---|
|   |                 | TO-252            | TO-220         |           |   |
| Drain-source voltage                                | $V_{DS}$        | 60                |                | V         |   |
| Gate-source voltage                                 | $V_{GS}$        | ±20               |                | V         |   |
| Continuous drain current $V_{GS}@-10V^1$            | $I_D$           | $T_C=25^\circ C$  | 50             | A         |   |
|   |                 | $T_C=100^\circ C$ | 30             |           |   |
| Pulsed drain current <sup>2</sup>                   | $I_{DM}$        | 100               |                | A         |   |
| Single pulse avalanche energy <sup>3</sup>          | EAS             | 72.2              |                | mJ        |   |
| Avalanche current                                   | $I_{AS}$        | 38                |                | A         |   |
| Total power dissipation <sup>4</sup>                | $P_D$           | $T_C=25^\circ C$  | 52             | 80        | W |
| Junction and storage temperature range              |                 |                   | $T_J, T_{STG}$ | -55 to150 |   |
| Thermal resistance-junction to ambient <sup>1</sup> | $R_{\theta JA}$ | 62                | -              | °C/W      |   |
| Thermal resistance-junction to case <sup>1</sup>    | $R_{\theta JC}$ | 2.4               | 1.56           | °C/W      |   |

## 5. Ordering Information

| Part Number | Package | Brand |
|-------------|---------|-------|
| KNP3706A    | TO-220  | KIA   |
| KND3706A    | TO-252  | KIA   |

## 6. Electrical characteristics

( $T_J=25^{\circ}\text{C}$ , unless otherwise noted)

| Parameter                                       | Symbol       | Test Conditions   | Min | Typ  | Max       | Units      |
|---|--------------|---|-----|------|-----------|------------|
| Drain-Source breakdown voltage                  | $BV_{DSS}$   | $V_{GS}=0V, I_D=-250\mu A$                                | 60  | -    | -         | V          |
| Static drain-source on- resistance <sup>2</sup> | $R_{DS(on)}$ | $V_{GS}=10V, I_D=15A$                                     | -   | 9    | 12        | m $\Omega$ |
| Gate threshold voltage                          | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$                             | 2   | -    | 4         | V          |
| Drain-Source Leakage Current                    | $I_{DSS}$    | $V_{DS}=48V, V_{GS}=0V, T_J=25^{\circ}\text{C}$           | -   | -    | 1         | $\mu A$    |
|   |              | $V_{DS}=48V, V_{GS}=0V, T_J=25^{\circ}\text{C}$           | -   | -    | 5         | $\mu A$    |
| Gate-source leakage current                     | $I_{GSS}$    | $V_{GS}=\pm 20V, V_{DS}=0V$                               | -   | -    | $\pm 100$ | nA         |
| Forward transconductance                        | $g_{FS}$     | $V_{DS}=5V, I_D=30A$                                      | -   | 42   | -         | S          |
| Total gate charge(4.5V)                         | $Q_g$        | $V_{DS}=48V, V_{GS}=10V$<br>$I_D=15A$                     | -   | 33   | -         | nC         |
| Gate-source charge                              | $Q_{gs}$     |   | -   | 11   | -         |            |
| Gate-drain charge                               | $Q_{gd}$     |   | -   | 9.5  | -         |            |
| Turn-on delay time                              | $t_{d(on)}$  | $V_{DD}=30V,$<br>$R_G=3.3\Omega, V_{GS}=10V$<br>$I_D=15A$ | -   | 10.5 | -         | ns         |
| Rise time                                       | $t_r$        |   | -   | 9.0  | -         |            |
| Turn-off delay time                             | $t_{d(off)}$ |   | -   | 65   | -         |            |
| Fall time                                       | $t_f$        |   | -   | 4.5  | -         |            |
| Input capacitance                               | $C_{iss}$    | $V_{GS}=0V, V_{DS}=15V$<br>$F=1.0\text{MHz}$              | -   | 2180 | -         | pF         |
| Output capacitance                              | $C_{oss}$    |   | -   | 255  | -         |            |
| Reverse transfer capacitance                    | $C_{rss}$    |   | -   | 170  | -         |            |
| Diode characteristics                           |              |   |     |      |           |            |
| Continuous source current <sup>1,5</sup>        | $I_S$        | $V_G=V_D=0V, \text{Force current}$                        | -   | -    | 30        | A          |
| Diode forward voltage <sup>2</sup>              | $V_{SD}$     | $V_{GS}=0V, I_S=1A, T_J=25^{\circ}\text{C}$               | -   | -    | 1.2       | V          |
| Reverse recovery time                           | $t_{rr}$     | $I_F=15A, di/dt=100A/\mu s,$<br>$T_J=25^{\circ}\text{C}$  | -   | 19   | -         | nS         |
| Reverse recovery charge                         | $Q_{rr}$     |   | -   | 15   | -         | nC         |

Note:1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

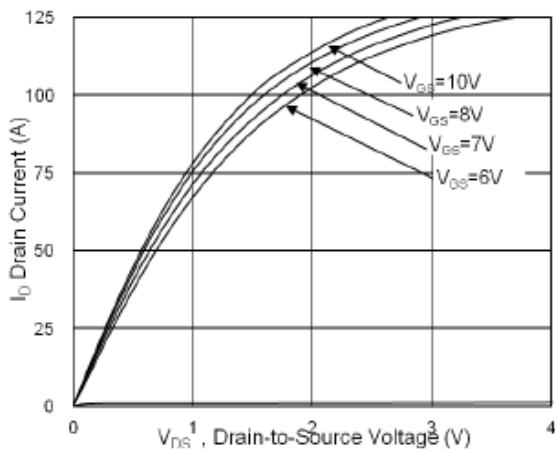
2. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .

3. The EAS data shows Max.rating. The test condition is  $V_{DD}=25V, V_{GS}=10V, L=0.1\text{mH}, I_{AS}=38A$ .

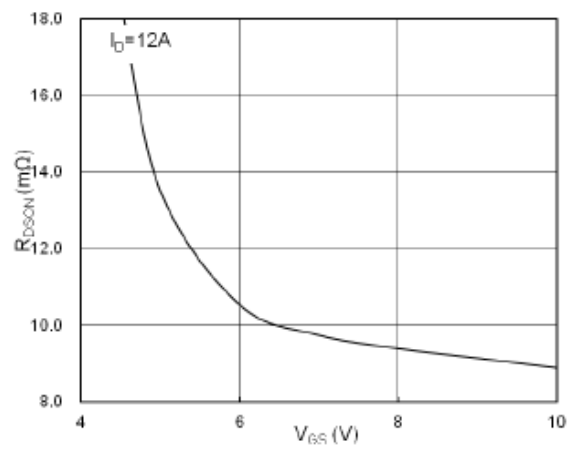
4. The power dissipation is limited by 150 °C junction temperature.

5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

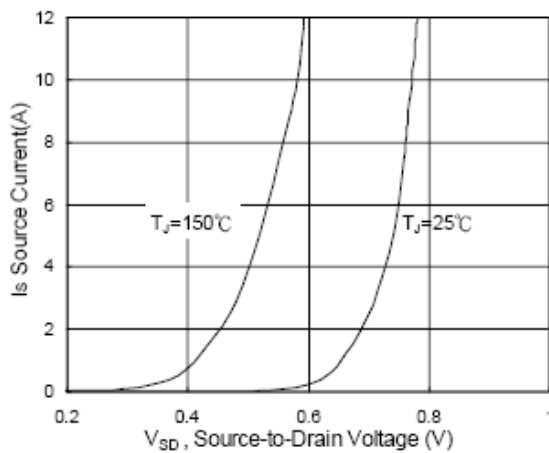
**7. Test circuits and waveforms**



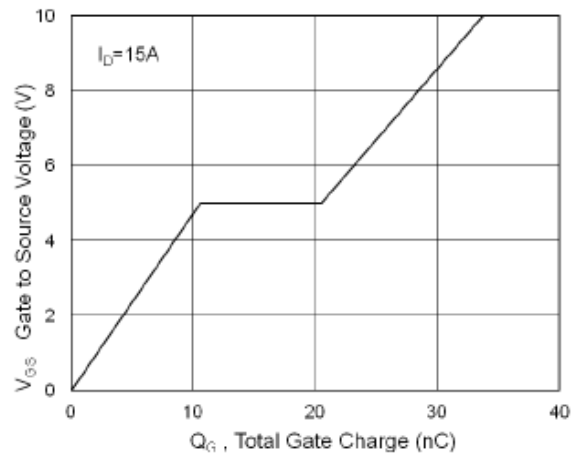
**Fig.1 Typical Output Characteristics**



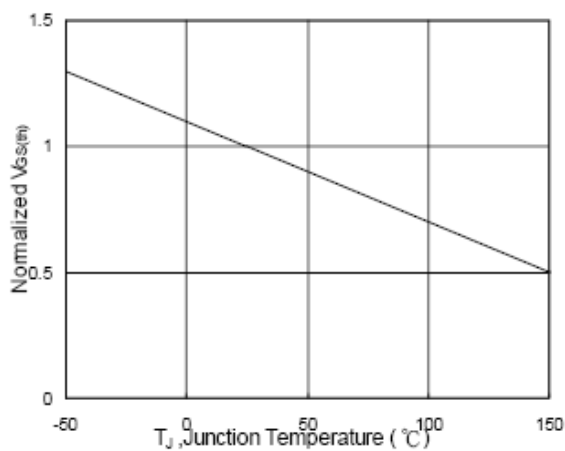
**Fig.2 On-Resistance vs. G-S Voltage**



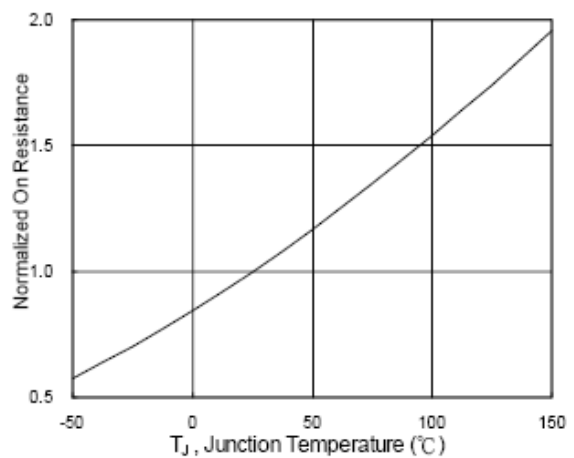
**Fig.3 Source Drain Forward Characteristics**



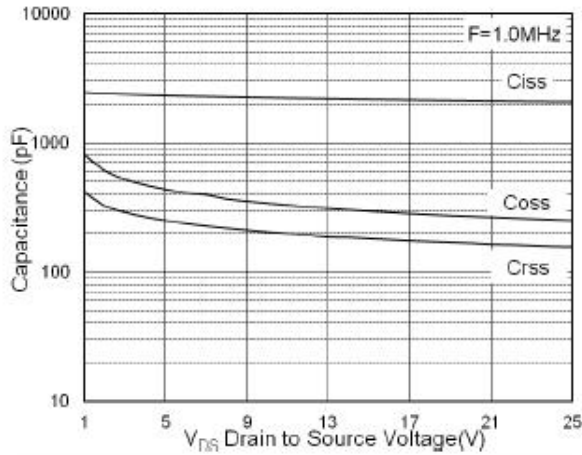
**Fig.4 Gate-Charge Characteristics**



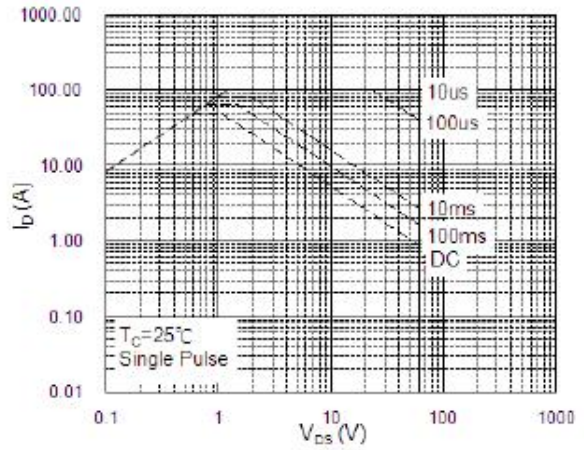
**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**



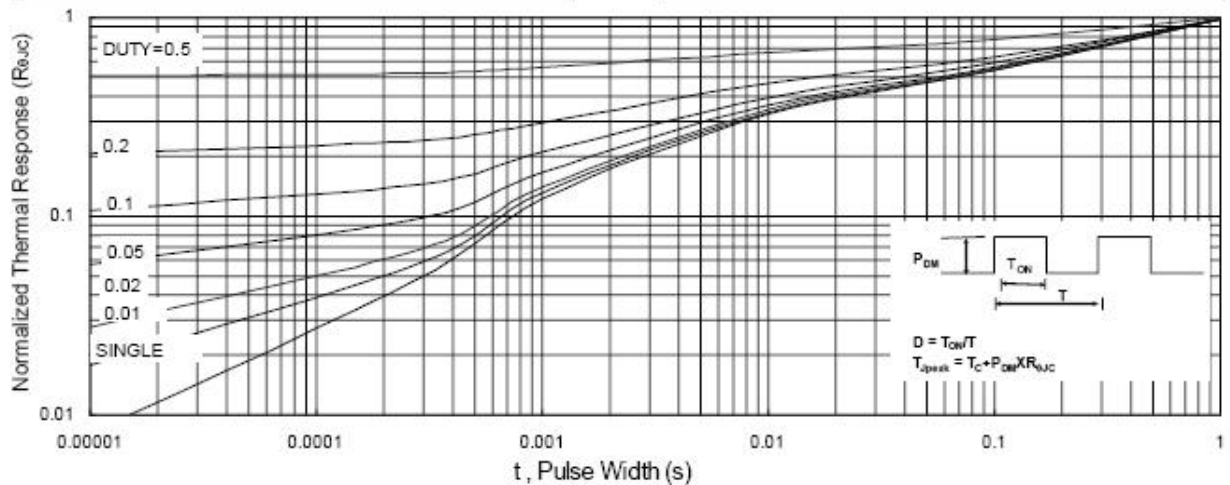
**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**



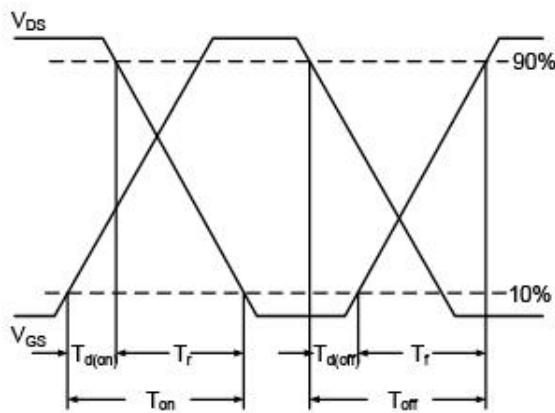
**Fig.7 Capacitance**



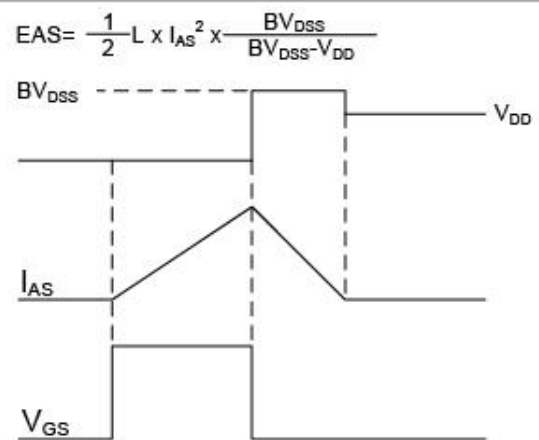
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

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